 en notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/764,518	MIYATA ET AL.	
Examiner	Art Unit	
Christina Y. Leung	2613	

SEARCHED				
Class	Subclass	Date	Examiner	
398	83-85	6/26/2006	CL	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST text search (see search history)	6/26/2006	CL		